

TEST REPORT

Application No.: SZCR2506002312MO
Applicant: Rolling Wireless S.a r.l.
Address of Applicant: 8-10, rue Mathias Hardt 1717, Luxembourg
Manufacturer: Rolling Wireless S.a r.l.
Address of Manufacturer: 8-10, rue Mathias Hardt 1717, Luxembourg
EUT Description: Cat.1bis Module
Model No.: RW220-GL
Trade Mark: Rolling Wireless
FCC ID: 2AX2URW220GL
Standards: 47 CFR Part 2
 47 CFR Part 22
 47 CFR Part 27
 47 CFR Part 90
Date of Receipt: 2025/06/03
Date of Test: 2025/06/05 to 2025/06/25
Date of Issue: 2025/06/27

Test Result :	PASS *
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* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Keny Xu

Keny Xu
EMC Laboratory Manager



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Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2025/06/27		Original

Authorized for issue by:				
		Donjon . Huang		
		Donjon Huang/Project Engineer		
		Eric Fu		
		Eric Fu/Reviewer		



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2 Test Summary

2.1 LTE Band 5/26(824~849 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913(a)(5)	ERP ≤ 7 W	Refer to the Appendixs	Pass
Peak-Average Ratio	§22.913(d)	Limit≤13 dB		Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.		Pass
Band Edges Compliance	§2.1051, §22.917(a)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.		Pass
Spurious Emission at Antenna Terminals	§2.1051, §22.917(a)	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges.		Pass
Field Strength of Spurious Radiation	§2.1053, §22.917(a)	FCC: ≤ -13 dBm/100 kHz.		Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §22.355	±2.5ppm.		Pass



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2.2 LTE Band 12

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046 §27.50(c)(10)	ERP ≤ 3 W.	Refer to the Appendixs	Pass
Peak-Average Ratio	---	Limit≤13 dB		Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.		Pass
Band Edges Compliance	§2.1051, §27.53(g)	≤ 43+10log10(P[Watts])		Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(g)	≤ 43+10log10(P[Watts])		Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(g)	FCC: ≤ -13 dBm/100 kHz.		Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §27.54	Within authorized bands of operation/frequency block.		Pass



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2.3 LTE Band 26(814~824 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Transmitter Conducted Power Output	§2.1046, §90.635(b)	< 100 W.	Refer to the Appendixs	Pass
Peak-Average Ratio	---	Limit≤13 dB		Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.		Pass
Emission Mask	§2.1051 § 90.691(a)	For any frequency removed from the EA licensee's frequency block by up to and including 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least 116 Log10(f/6.1) decibels or 50+10Log10(P) decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 12.5 kHz.		Pass
Spurious Emission at Antenna Terminals	§2.1051, §90.691	< 43 + 10Log10(P[Watts]) for all out-of-band emissions		Pass
Field Strength of Spurious Radiation	§2.1053, §90.691	< 43 + 10Log10(P[Watts]) for all out-of-band emissions		Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §90.213	Within authorized bands of operation/frequency block.		Pass



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4 General Information

4.1 General Description of EUT

Hardware Version:	V1.2		
Software Version:	13600.1000.00.03.00.02		
Power Supply:	DC 3.3V		
IMEI:	RF Conducted	353628920000321	
	RSE	353628920000339	
Antenna Type:	☒ External, ☐ Integrated		
Antenna Gain:	LTE Band 5: 3dBi		
	LTE Band 12: 3dBi		
	LTE Band 26: 3dBi		
	Note: The antenna gain are derived from the gain information report provided by the manufacturer.		
RF Cable:	9kHz ~ 30MHz (0.3dB)	30MHz ~ 1000MHz (0.6dB)	1000MHz ~ 2000MHz (0.8dB)
	2000MHz ~ 4000MHz (1.1dB)	4000MHz ~ 6000MHz (1.8dB)	6000MHz ~ 12750MHz (2.6dB)
	Above 12750MHz(3.5dB)		
Remark: As above information is provided and confirmed by the applicant. SGS is not liable to the accuracy, suitability, reliability or/and integrity of the information.			



4.2 Test Mode

Test Mode	Test Modes Description
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
Remark: The test mode(s) are selected according to relevant radio technology specifications.	

4.3 Test Environment

Environment Parameter	101.0 kPa Selected Values During Tests	
Relative Humidity	45-56 % RH Ambient	
Value	Temperature(°C)	Voltage(V)
NTNV	22~25	3.3
LTLV	-30	3.135
LTHV	-30	4.4
HTLV	50	3.135
HTHV	50	4.4
Remark:		
NV: Normal Voltage	LV: Low Extreme Test Voltage	HV: High Extreme Test Voltage
NT: Normal Temperature	LT: Low Extreme Test Temperature	HT: High Extreme Test Temperature

4.4 Description of Support Units

Description	Manufacturer	Model No.
Motherboard	Rolling Wireless	EVB-M2V1.2
Adapter	Huntkey	MC-101
Type-C Cable	SGS	N/A



4.5 Measurement Uncertainty

For a 95% confidence level ($k = 2$), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

No.	Item	Measurement Uncertainty
1	Total RF power, conducted	$\pm 0.41\text{dB}$
2	RF power density, conducted	$\pm 1.96\text{dB}$
3	Spurious emissions, conducted	$\pm 0.41\text{dB}$
4	Radio Frequency	$\pm 7.10 \times 10^{-8}$
5	Duty Cycle	$\pm 0.49\%$
6	Occupied Bandwidth	$\pm 0.2\%$
7	Radiated Emissions below 1GHz	$\pm 6.0\text{dB}$ for 3m; $\pm 5.0\text{dB}$ for 10m
8	Radiated Emissions Above 1GHz	$\pm 4.6\text{dB}$ (1-18GHz); $\pm 4.8\text{dB}$ (18-40GHz)

Remark:

The U_{lab} (lab Uncertainty) is less than $U_{\text{CISPR/ETSI}}$ (CISPR/ETSI Uncertainty), so the test results

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.



4.6 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

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Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI (Member No. 1937)

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen EMC laboratory have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC –Designation Number: CN1336

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1336. Test Firm Registration Number: 787754.

• Innovation, Science and Economic Development Canada

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.



4.8 Technical Specification

Characteristics	Description				
Radio System Type	☒ LTE				
Supported Frequency Range	Band	TX		RX	
	LTE Band 5	824 to 849 MHz		869 to 894 MHz	
	LTE Band 12	699 to 716 MHz		729 to 746 MHz	
	LTE Band 26 (814 to 824 MHz)	814 to 824MHz		859 to 869 MHz	
	LTE Band 26 (824 to 849 MHz)	824 to 849 MHz		869 to 894 MHz	
Supported Channel Bandwidth	LTE Band 5	☒ 1.4 MHz	☒ 3 MHz	☒ 5 MHz	☒ 10 MHz
	LTE Band 12	☒ 1.4 MHz	☒ 3 MHz	☒ 5 MHz	☒ 10 MHz
	LTE Band 26(814-824)	☒ 1.4 MHz	☒ 3 MHz	☒ 5 MHz	☒ 10 MHz
	LTE Band 26(824-849)	☒ 1.4 MHz	☒ 3 MHz	☒ 5 MHz	☒ 10 MHz
		☒ 15 MHz			



4.9 Equipment List

RF conducted test					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy/mm/dd)	Cal.Due date (yyyy/mm/dd)
Humidity/ Temperature Indicator	Deli	8838	SEM002-40	2024/07/24	2025/07/23
Spectrum Analyzer	KEYSIGHT	N9020A	SEM004-19	2025/01/07	2026/01/06
DC power supply	HYELEC	HY3005B	SZ-WRG-M-044	2024/08/21	2025/08/20
Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	SZ-WRG-M-033	2025/01/07	2026/01/06
Wideband Radio Communication Tester	Anristu	MT8821C	SEM010-09	2025/03/04	2026/03/03
Programmable Temperature & Humidity Chamber	Votsch Industrietechnik GmbH	VT 4002	SEM002-15	2024/07/30	2025/07/29
Signal Generator	KEYSIGHT	N5182A	SZ-WRG-M-041	2025/01/07	2026/01/06
Test Software	TST PASS	TST PASS V2.0	N/A	NCR	NCR



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Radiated spurious emissions					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy/mm/dd)	Cal.Due date (yyyy/mm/dd)
MXE EMI receiver(3Hz-3.6GHz)	KEYSIGHT	N9038B	SEM004-29	2024/08/14	2025/08/13
Signal & Spectrum Analyzer	Rohde & Schwarz	FSV	SZ-WRG-M-048	2025/01/07	2026/01/06
Pre-amplifier(30MHz-1GHz)	SGS	AMP30M1G30	SEM005-33	2025/03/04	2026/03/03
Low Noise Amplifier 30M-8GHz	Tonscend	TAP30M8G30	SZ-WRG-M-050	2025/01/07	2026/01/06
Low Noise Amplifier 1G-18GHz	Tonscend	TAP01018050	SZ-WRG-M-051	2025/01/07	2026/01/06
Low Noise Amplifier 18G-40GHz	Tonscend	TAP18040048	SZ-WRG-M-052	2025/01/08	2026/01/07
Active Loop Antenna 9kHz-30MHz	SCHWARZBECK	FMZB 1519B	SZ-WRG-M-053	2023/12/25	2025/12/24
TRILOG Breitband Antenne 30MHz-1GHz	SCHWARZBECK	VULB 9168	SZ-WRG-M-054	2023/12/25	2025/12/24
Double Ridge Horn Antenna 1GHz-18GHz	SCHWARZBECK	BBHA 9120 D	SZ-WRG-M-055	2023/12/21	2025/12/20
SHF-EHF Horn 15GHz-40GHz	SCHWARZBECK	BBHA 9170	SZ-WRG-M-056	2023/12/25	2025/12/24
RSE Test Software	Tonscend	JS32-RSE V4.0.0	SZ-WRG-M-058	NCR	NCR
RE Test Software	Tonscend	JS32-RE V4.0.0	SZ-WRG-M-059	NCR	NCR
Measurement Software	AUDIX	e3 V8.2014-6-27	NCR	NCR	NCR
Chamber	CRTSGSSAC966	N/A	SZ-WRG-C-063	2025/01/06	2028/01/05
Humidity/ Temperature Indicator	Deli	8838	SEM002-46	2024/07/24	2025/07/23
Spectrum Analyzer	Keysight	N9020A	SZ-WRG-M-002	2024/08/17	2025/08/16
Radio Communication Tester	Anritsu	MT8821C	SZ-WRG-M-014	2024/08/19	2025/08/18

Remark: NCR=No Calibration Requirement.



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4.10 Test Frequencies

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band 5	1.4MHz	TX	Channel 20407	Channel 20525	Channel 20643
			824.7 MHz	836.5 MHz	848.3 MHz
		RX	Channel 2407	Channel 2525	Channel 2643
			869.7 MHz	881.5 MHz	893.3 MHz
	3MHz	TX	Channel 20415	Channel 20525	Channel 20635
			825.5 MHz	836.5 MHz	847.5 MHz
		RX	Channel 2415	Channel 2525	Channel 2635
			870.5 MHz	881.5 MHz	892.5 MHz
	5MHz	TX	Channel 20425	Channel 20525	Channel 20625
			826.5 MHz	836.5 MHz	846.5 MHz
		RX	Channel 2425	Channel 2525	Channel 2625
			871.5 MHz	881.5 MHz	891.5 MHz
	10MHz	TX	Channel 20450	Channel 20525	Channel 20600
			829 MHz	836.5 MHz	844 MHz
		RX	Channel 2450	Channel 2525	Channel 2600
			874 MHz	881.5 MHz	889 MHz

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band 12	1.4MHz	TX	Channel 23017	Channel 23095	Channel 23173
			699.7 MHz	707.5 MHz	715.3 MHz
		RX	Channel 5017	Channel 5095	Channel 5173
			729.7 MHz	737.5 MHz	745.3 MHz
	3MHz	TX	Channel 23025	Channel 23095	Channel 23165
			700.5 MHz	707.5 MHz	714.5 MHz
		RX	Channel 5025	Channel 5095	Channel 5165
			730.5 MHz	737.5 MHz	744.5 MHz
	5MHz	TX	Channel 23035	Channel 23095	Channel 23155
			701.5 MHz	707.5 MHz	713.5 MHz
		RX	Channel 5035	Channel 5095	Channel 5155
			731.5 MHz	737.5 MHz	743.5 MHz
	10MHz	TX	Channel 23060	Channel 23095	Channel 23130
			704 MHz	707.5 MHz	711 MHz
		RX	Channel 5060	Channel 5095	Channel 5130
			734 MHz	737.5 MHz	741 MHz



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Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band 26 (814-824)	1.4MHz	TX	Channel 26697	Channel 26740	Channel 26783
			814.7 MHz	819 MHz	823.3 MHz
		RX	Channel 8697	Channel 8740	Channel 8783
			859.7 MHz	864MHz	868.3 MHz
	3MHz	TX	Channel 26705	Channel 26740	Channel 26775
			815.5 MHz	819 MHz	822.5 MHz
		RX	Channel 8705	Channel 8740	Channel 8775
			860.5 MHz	864MHz	867.5 MHz
	5MHz	TX	Channel 26715	Channel 26740	Channel 26765
			816.5 MHz	819 MHz	821.5 MHz
		RX	Channel 8715	Channel 8740	Channel 8765
			861.5 MHz	864MHz	866.5 MHz
	10MHz	TX	Channel 26740	Channel 26740	Channel 26740
			819 MHz	819 MHz	819 MHz
		RX	Channel 8740	Channel 8740	Channel 8740
			864MHz	864MHz	864MHz

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band26 (824-849)	1.4MHz	TX	Channel 26797	Channel 26915	Channel 27033
			824.7 MHz	836.5 MHz	848.3 MHz
		RX	Channel 8797	Channel 8915	Channel 9033
			869.7 MHz	881.5 MHz	893.3 MHz
	3MHz	TX	Channel 26805	Channel 26915	Channel 27025
			825.5 MHz	836.5 MHz	847.5 MHz
		RX	Channel 8805	Channel 8915	Channel 9025
			860.5 MHz	881.5 MHz	892.5 MHz
	5MHz	TX	Channel 26815	Channel 26915	Channel 27015
			826.5 MHz	836.5 MHz	846.5 MHz
		RX	Channel 8815	Channel 8915	Channel 9015
			871.5 MHz	881.5 MHz	891.5 MHz
	10MHz	TX	Channel 26840	Channel 26915	Channel 26990
			829 MHz	836.5 MHz	844 MHz
		RX	Channel 8840	Channel 8915	Channel 8990
			874 MHz	881.5 MHz	889 MHz
	15MHz	TX	Channel 26865	Channel 26915	Channel 26965
			831.5 MHz	836.5 MHz	841.5 MHz
		RX	Channel 8865	Channel 8915	Channel 8965
			876.5 MHz	881.5 MHz	886.5 MHz



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5 Description of Tests

5.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.2.1

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Remark: Reference test setup 1



5.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8.4

Calculate power in dBm by the following formula:

ERP (dBm) = Conducted Power (dBm) + antenna gain (dBd)

EIRP(dBm) = Conducted Power (dBm) + antenna gain (dBi)

EIRP=ERP+2.15dB



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5.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2 & 4.3

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel). The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7



5.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to rms.

Remark: Reference test setup 1

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW $\geq$ 1% of the emission bandwidth
4. VBW $\geq$ 3 x RBW
5. Detector = RMS
6. Number of sweep points $\geq$ 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize



5.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel). The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Remark: Reference test setup 1

Test Settings

1. Start frequency was set to 9kHz and stop frequency was set to at least 10* the fundamental frequency(Separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings



5.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.2

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's CCDF measurement profile is enabled
2. Frequency = carrier center frequency
3. Measurement BW > Emission bandwidth of signal
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power



5.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). Test the EUT in the lowest channel, the middle channel ,the Highest channel.
- 5). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 6). Repeat above procedures until all frequencies measured was complete.

$$E \text{ (dB}\mu\text{V/m)} = \text{Measured amplitude level (dB}\mu\text{V)} + (\text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)} - \text{AMP(dB)})$$

$$\text{EIRP (dBm)} = E \text{ (dB}\mu\text{V/m)} + 20 \log D - 104.8; \text{ where D is the measurement distance in meters}$$

Above 1GHz test procedure as below:

- 1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

$$E \text{ (dB}\mu\text{V/m)} = \text{Measured amplitude level (dB}\mu\text{V)} + (\text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)} - \text{AMP(dB)})$$

$$\text{EIRP (dBm)} = E \text{ (dB}\mu\text{V/m)} + 20 \log D - 104.8; \text{ where D is the measurement distance in meters}$$
- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete

Remark1: Reference test setup 2

Remark2: The emission below 18G were measured at a 3m test distance, while emissions above 18GHz were measured at a 1m test distance. At a measurement distance of 1 meter the limit line was increased by $20 \cdot \log(3/1) = 9.54 \text{ dB}$.

Remark: Reference test setup 2

Remark:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & AMP. The basic equation with a sample calculation is as follows:

AF = Antenna Factor(dB/m)

Factor = Cable Factor(dB) - Preamplifier (dB)

Level = Reading Level + AF + Factor -95.26

Margin = Limit – Level

2) Scan from 9kHz to 40GHz, The disturbance between 9KHz to 30MHz and 18GHz to 40GHz was very low, and the harmonics were the highest point could be found when testing, so only the harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

3) All modes have been tested, but only the worst case data displayed in this report.



5.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; Section 9

. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Time Period and Procedure:

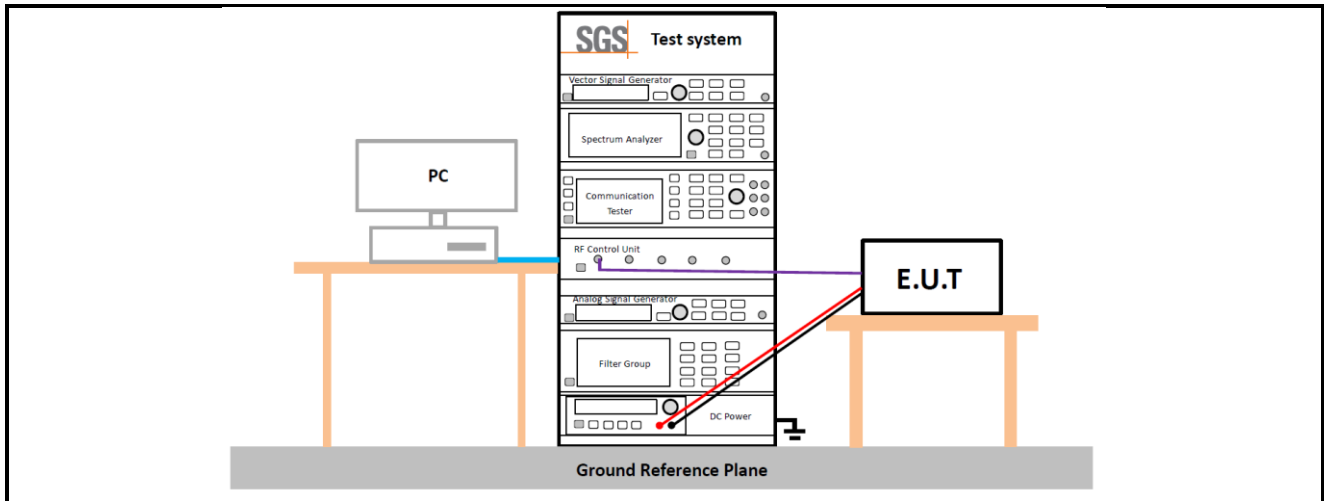
1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Remark: Reference test setup 3



5.9 Test Setups

5.9.1 Test Setup 1



5.9.2 Test Setup 2

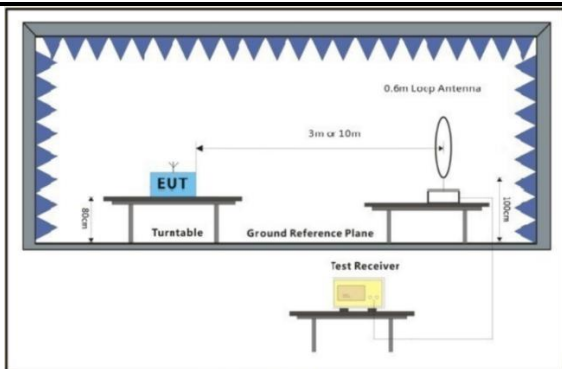


Figure 1. Below 30MHz

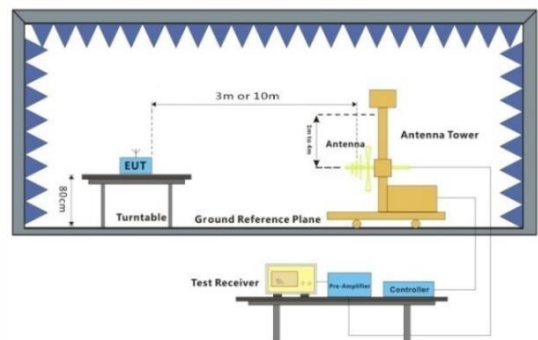


Figure 2. 30MHz to 1GHz

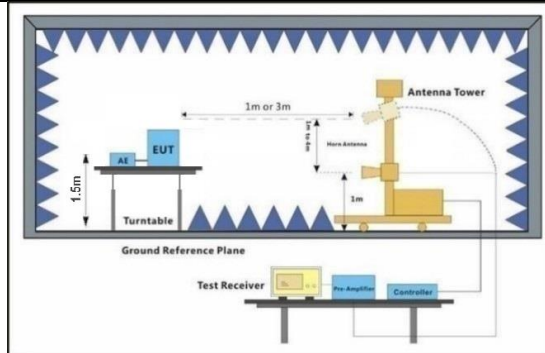
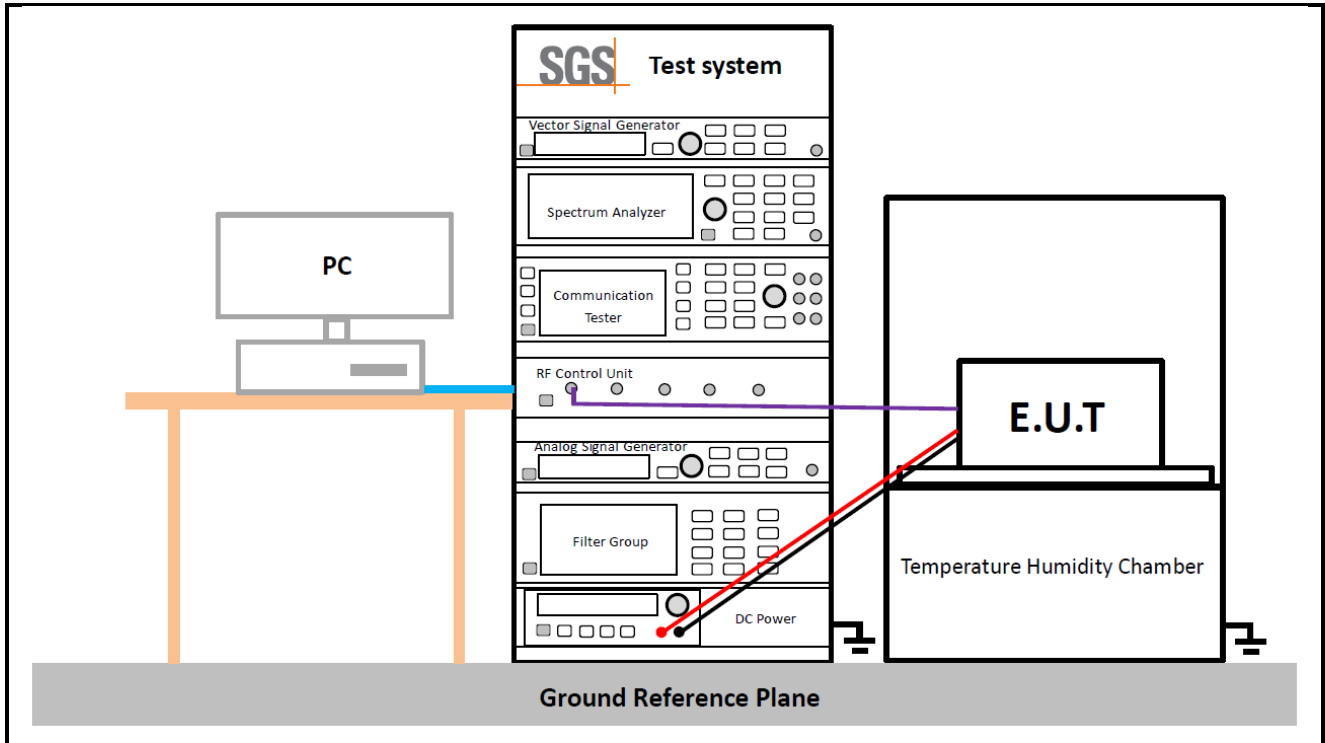


Figure 3. above 1GHz



5.9.3 Test Setup 3



5.10 Test Conditions

Transmit Output Power Data - Average Power, Total	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2
Peak-to-Average Ratio	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2
Bandwidth - Occupied Bandwidth	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2
Bandwidth - Emission Bandwidth	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2
Band Edges Compliance	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, H (L= low channel, H= high channel)



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Test Mode	LTE/TM1
Spurious Emission at Antenna Terminals	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1
Field Strength of Spurious Radiation	
Test Case	Test Conditions
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 2
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1 Remark: All bandwidth and modulation of LTE have been pre tested, and only the worst results are reflected in the report.
Frequency Stability	
Test Case	Test Conditions
Test Environment	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage (2) VL, VN and VH of Rated Voltage at Ambient Climate.
Test Setup	Test Setup 3
RF Channels (TX)	M (M= middle channel)
Test Mode	LTE/TM1



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6 Appendixes

SZCR2506002312 Appendix	Setup Photo
Appendix B.1	LTE Band 5
Appendix B.2	LTE Band 12
Appendix B.3	LTE Band 26(814-824)
Appendix B.4	LTE Band 26(824-849)

---End of Report---

